

• General Description

The TFD180N06N combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

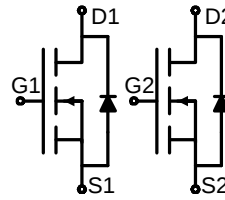
• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Dual DIE in one package

• Application

- Power Management in Notebook Computer,
- Portable Equipment and Battery
- Powered Systems

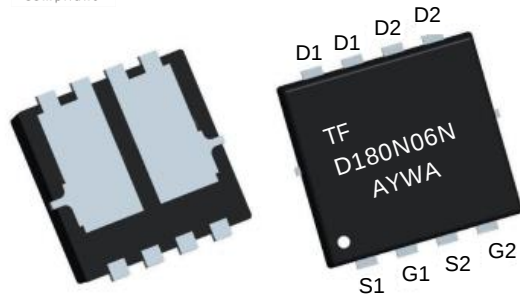
• Product Summary



$$V_{DS} = 60V \quad I_D = 25A$$

$$R_{DS(ON)(10V \text{ typ})} = 17m\Omega$$

$$R_{DS(ON)(4.5V \text{ typ})} = 23m\Omega$$



PDFNWB5x6-8L

• Package Marking and Ordering Information:

Part NO.	TFD180N06N
Marking1	D180N06N
Marking2	TF:tuofeng; AA:device code; Y:year code; X:Week
Basic ordering unit	5000 / PCS

• Absolute Maximum Ratings ($T_C = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_{D@TC=25^\circ C}$	25	A
	$I_{D@TC=75^\circ C}$	18	A
	$I_{D@TC=100^\circ C}$	15	A
Pulsed Drain Current ①	I_{DM}	70	A
Total Power Dissipation	$P_D@TC=25^\circ C$	40	W
Total Power Dissipation	$P_D@TA=25^\circ C$	1.5	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ C$
Storage Temperature	T_{STG}	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	80	mJ

●Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	8.5	° C/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	75	° C/W
Soldering temperature, wavesoldering for 8 s	T_{sold}	-	-	265	° C

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2	1.5	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=60V, V_{GS}=0V$	-	-	1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$	-	17	20	m Ω
		$V_{GS}=4.5V, I_D=15A$	-	23	26	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=25V, I_D=10A$	-	10	-	S
Source-drain voltage	V_{SD}	$I_S=10A$	-	-	1.20	V

●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C_{iss}	f = 1MHz $V_{DS}=30V$ $V_{GS}=0V$	-	1000	-	pF
Output capacitance	C_{oss}		-	108	-	
Reverse transfer capacitance	C_{rss}		-	96.9	-	

●Gate Charge characteristics($T_a = 25^\circ C$)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q_g	$V_{DD}=30V$	-	15.0	-	nC
Gate - Source charge	Q_{gs}	$I_D=15A$	-	4.5	-	
Gate - Drain charge	Q_{gd}	$V_{GS}=10V$	-	7.5	-	

Note: ① Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$;

Fig.1 Power Dissipation

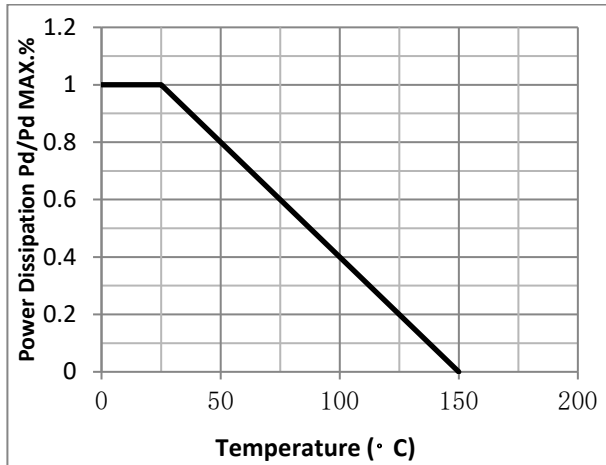


Fig.2 Typical output Characteristics

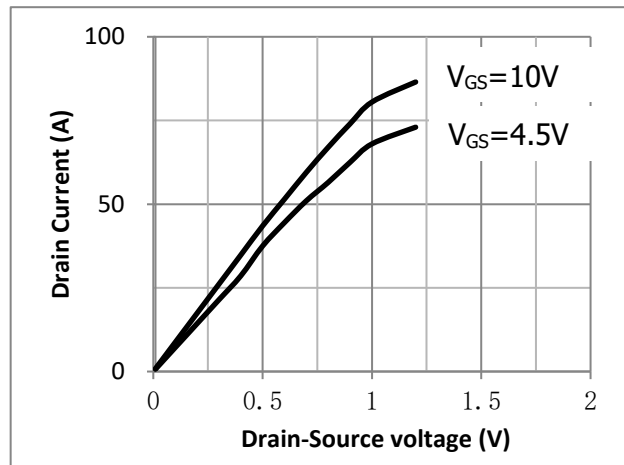


Fig.3 Threshold Voltage V.S Junction Temperature

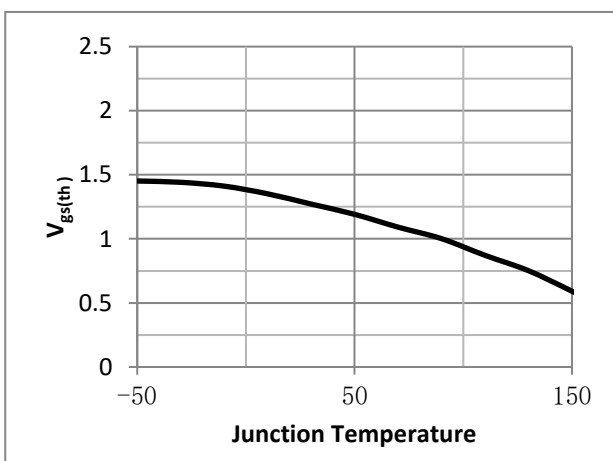


Fig.4 Resistance V.S Drain Current

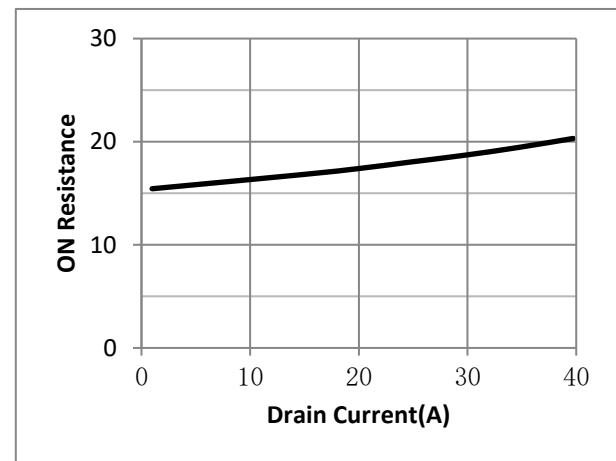


Fig.5 On-Resistance VS Gate Source Voltage

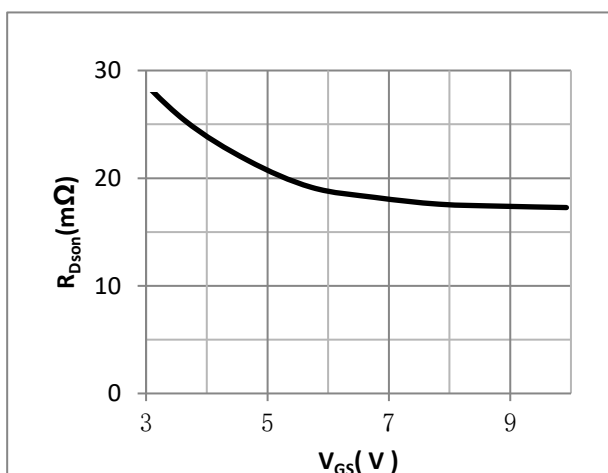


Fig.6 On-Resistance V.S Junction Temperature

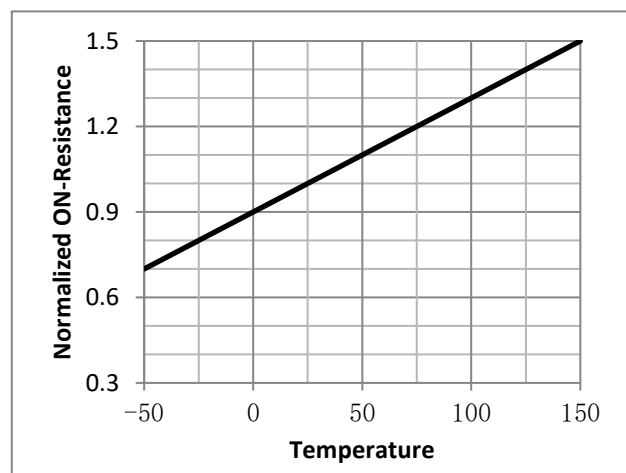


Fig.7 Switching Time Measurement Circuit

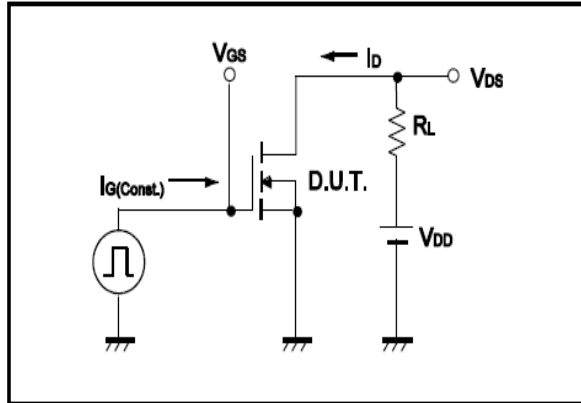


Fig.8 Gate Charge Waveform

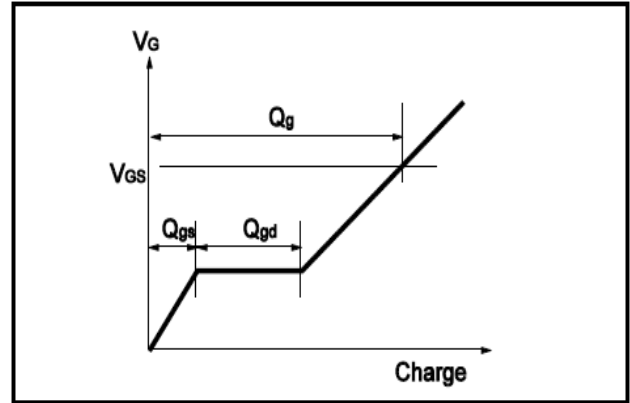


Fig.9 Switching Time Measurement Circuit

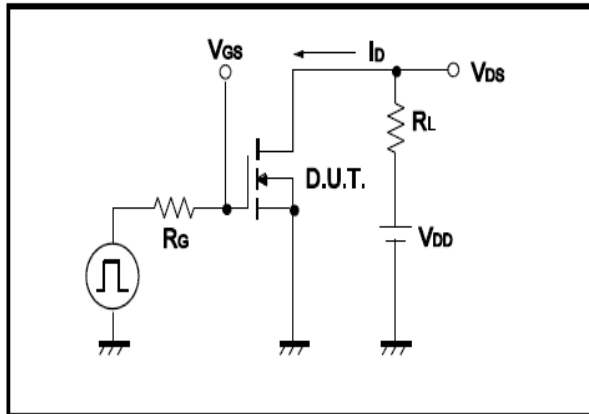


Fig.10 Gate Charge Waveform

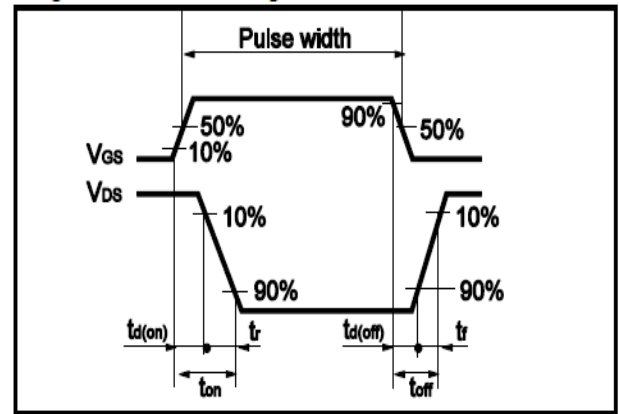


Fig.11 Avalanche Measurement Circuit

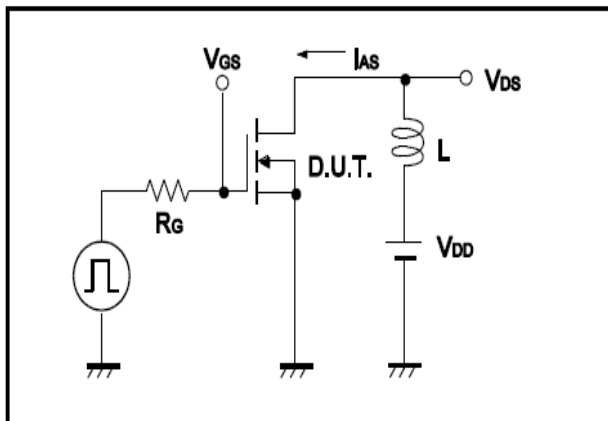
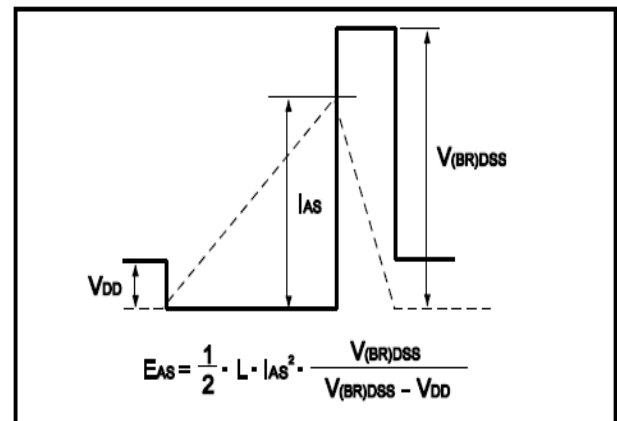
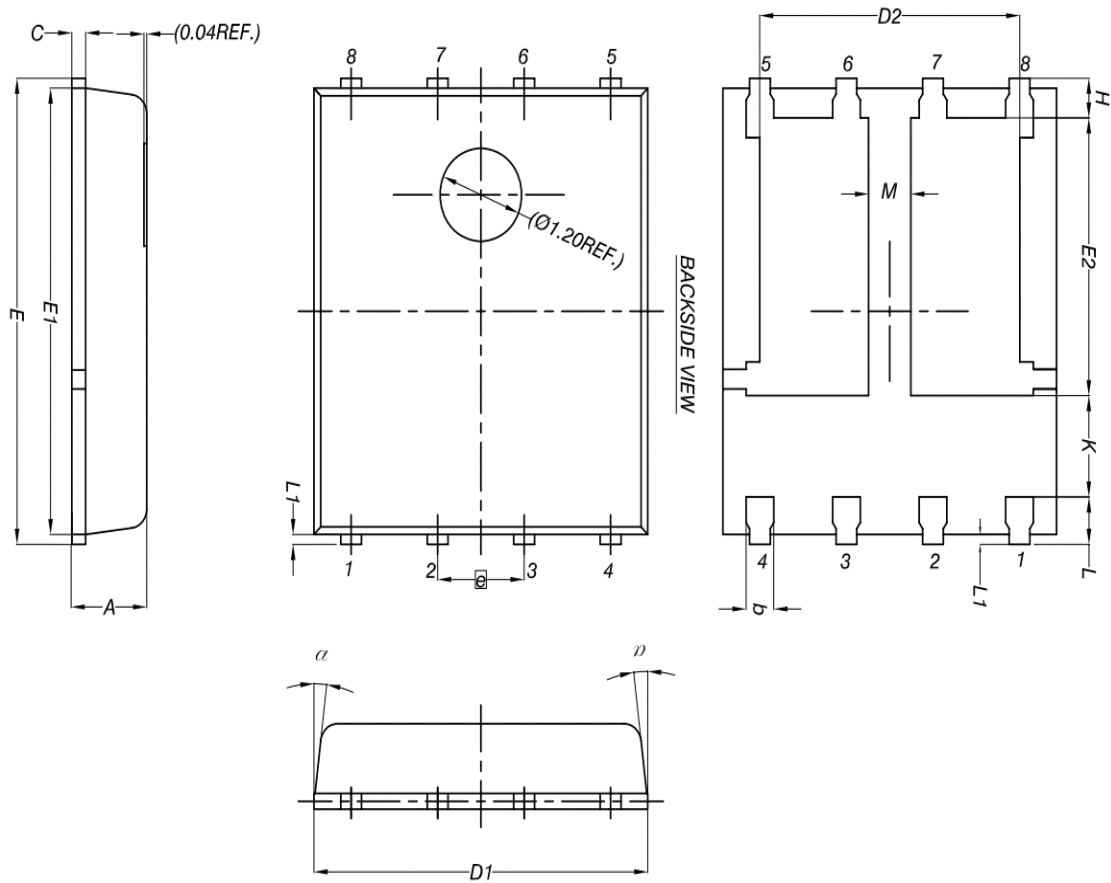


Fig.12 Avalanche Waveform



PDFNWB5x6-8L Package Outline Dimensions



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.9	1	1.1
b	0.33	0.41	0.51
C	0.2	0.25	0.3
D1	4.8	4.9	5
D2	3.61	3.81	3.96
E	5.9	6	6.1
E1	5.7	5.75	5.8
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.1	--	--
L	0.51	0.61	0.71
L1	0.06	0.13	0.2
M	0.5	--	--
α	0°	--	12°

Note:
 1. Controlling dimension: in millimeters.
 2. General tolerance: ± 0.05 mm.
 3. The pad layout is for reference purposes only.